

Notice of References Cited

Application/Control No.

10/763,284

Applicant(s)/Patent Under
Reexamination
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Examiner

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Art Unit

3709

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,468,162 B1	10-2002	Nakamura, Takashi	463/43
*	B	US-5,534,685	07-1996	Takemoto et al.	235/487
*	C	US-2001/0034257 A1	10-2001	Weston et al.	463/1
*	D	US-2004/0169086 A1	09-2004	Ohta et al.	235/492
*	E	US-2002/0028710 A1	03-2002	Ishihara et al.	463/44
*	F	US-5,448,280	09-1995	Matsuda et al.	347/171
*	G	US-2004/0002387 A1	01-2004	Grady, Daniel Patrick	463/43
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000155826 A	06-2000	Japan	MURATA, SHINSUKE	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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